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Electrical ratings 1

Table 1.	Absolute	maximum	ratings
	Abounde	IIIUAIIIIUIII	ruungo

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage ($V_{GS} = 0$)	400	V
V _{DGR}	Drain-gate voltage (R _{GS} = 20 kΩ)	400	V
V _{GS}	Gate- source voltage	± 20	V
I _D	Drain current (continuos) at $T_C = 25^{\circ}C$	5.5	А
Ι _D	Drain current (continuos) at $T_C = 100^{\circ}C$	3.5	A
I _{DM} ⁽¹⁾	Drain current (pulsed)	22	A
P _{TOT}	Total dissipation at $T_C = 25^{\circ}C$	100	W
	Derating factor	0.8	W/°C
dv/dt ⁽²⁾	Peak diode recovery voltage slope	3	V/ns
T _{stg}	Storage temperature	-65 to 150	°C
Тj	Max. operating junction temperature	150	°C
1. Pulse wid	Ith limited by safe operating area	200	
2. I _{SD} ≤5.5A	n, di/dt ≤90A/μs, V _{DD} ≤V _{(BR)DSS,} Ti ⊆ī _{j,na} .,	Ker'	
Table 2.	Thermal data		-
	The survey of the second states and the second states and the second states and the second states are second states and the second states are second states	1.05	0000

Table 2.	Thermal data
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Rthj-case	Thermal resistance unction-case max	1.25	°C/W
Rthj-amb	Thermal revisiance junction-ambient max	62.5	°C/W
Rthc-sink	The matresistance case-sink typ	0.5	°C/W
Т	Maximum lead temperature for soldering purpose	300	°C

Table 3.	Avalanche characteristics
	7776

Max Value	Unit
5.5	А
300	mJ
-	5.5



2 **Electrical characteristics**

(T_{CASE}=25°C unless otherwise specified)

Table 4.	On/off
	01//011

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 250 μA, V _{GS} = 0	400			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V_{DS} = max rating V_{DS} = max rating, T_{C} = 125 °C			1 50	μΑ uA
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	$V_{GS} = \pm 20V$		20	+100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2	3	4	v
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10V, I _D = 3 A		0.75	T	Ω
		lete		90		
Table 5.	Dynamic		~	<u> </u>		

Table 5. Dynamic

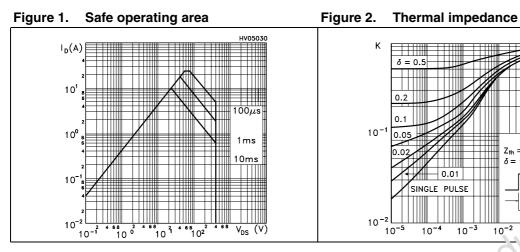
		Bynanno					
	Symbol	Parameter	'es' conditions	Min.	Тур.	Max.	Unit
	9 _{fs} ⁽¹⁾	Forward transconductance	$V_{L^{\circ}} > I_{D(on)} \times R_{DS(on)max},$ $I_{D} = 3 \text{ A}$	2.9			S
	C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reversed transfer cape cit unce	V _{DS} = 25V, f = 1 MHz, V _{GS} = 0		530 90 15		pF pF pF
18	$\begin{array}{c} t_{d(c n)} \\ t_{r} \\ t_{r',off} \\ t_{f} \end{array}$	Turn-on delay time Rise time Off-voltage rise time Fall time	$V_{DD} = 200V$, $I_D = 3A$ $R_G = 4.7\Omega V_{GS} = 10V$		11 15		ns ns ns ns
3050°	Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V _{DD} = 320V, I _D =5.5A, V _{GS} = 10V		18 4 8.5	24	nC nC nC
0105018	1. Pulsed: F	Pulse duration = 300 μs, duty c	ycle 1.5 %.				

ISD ISDM ⁽¹⁾ V _{SD} ⁽²⁾ t _{rr} Q _{rr} I _{RRM} 1. Pulse widt 2. Pulsed: Pu	Parameter Source-drain current Source-drain current (pulsed) Forward on voltage Reverse recovery time Reverse recovery charge Reverse recovery current th limited by safe operating are ulse duration = 300 µs, duty cy	rcle 1.5 %	Min.	Typ. 280 1.4 10	Max. 6 24 1.6	Uni A A V ns μC A
ISD ISDM ⁽¹⁾ V _{SD} ⁽²⁾ t _{rr} Q _{rr} I _{RRM} 1. Pulse widt 2. Pulsed: Pu	Source-drain current (pulsed) Forward on voltage Reverse recovery time Reverse recovery charge Reverse recovery current th limited by safe operating are rulse duration = 300 µs, duty cy	$I_{SD} = 7A$, di/dt = 100A/µs, V _{DD} = 100V, T _j = 150°C ea. rcle 1.5 %	Pro	1.4 10	24	A V ns μC A
t _{rr} Q _{rr} I _{RRM} 1. Pulse widt 2. Pulsed: Pu	Reverse recovery time Reverse recovery charge Reverse recovery current th limited by safe operating are rulse duration = 300 µs, duty cy	$I_{SD} = 7A$, di/dt = 100A/µs, V _{DD} = 100V, T _j = 150°C ea. rcle 1.5 %	Pro	1.4 10		ns μC Α
Q _{rr} I _{RRM} 1. Pulse widt 2. Pulsed: Pu	Reverse recovery charge Reverse recovery current th limited by safe operating are ulse duration = 300 µs, duty cy	V _{DD} = 100V, T _j = 150°C ea. role 1.5 %	Pro	1.4 10	cile	μC A
2. Pulsed: Pu	th limited by safe operating are rulse duration = 300 μs, duty cy	ea. role 1.5 %	Pro	991N		
	15	Obsolete	Pro	000 000	cile	3
	16	Obsolete	Pro	991	Cr	
	16)	Obsure	Pri			
	16)	coleite				
	ducil	005				
Pr	(00 - (S)	·				
lete	ducr					
0° - P'	(00					
lete						
)`						

Table 6. Source drain diode



2.1 **Electrical characteristics (curves)**







10-4

0.01

 10^{-3}

SINGLE PULSE

 $Z_{th} = k R_{thJ-c}$

 $1^{1-1} t_{p}(s)$

 $\delta={\rm t_p}/\tau$

10-2

Static drain-source on resistance

57

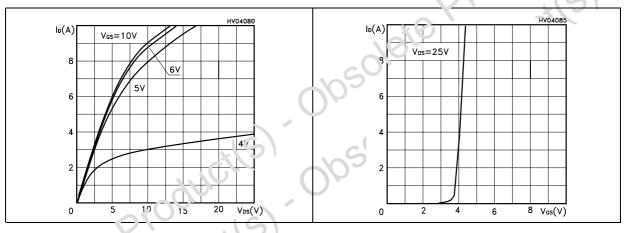
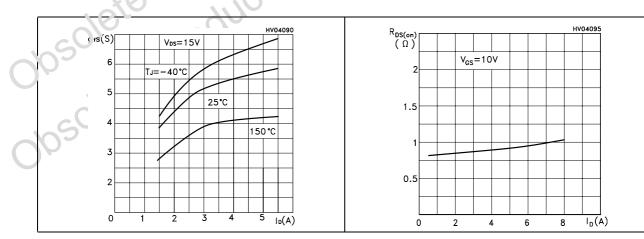


Figure 6.





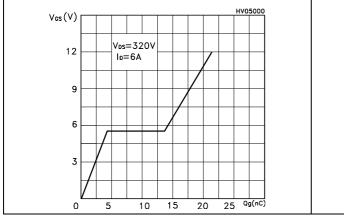


Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

Figure 9. Normalized gate threshold voltage vs temperature

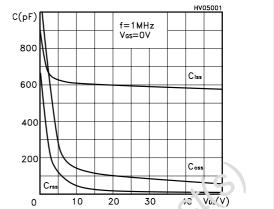


Figure 10. Normalized on resistance vs temperature

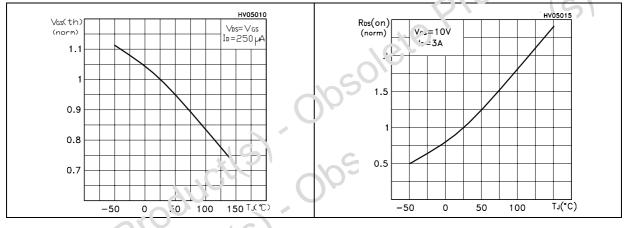
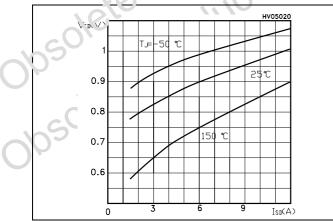


Figure 11. Source-drain diode forward cheracteristics



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3 Test circuit

Figure 12. Unclamped Inductive load test circuit

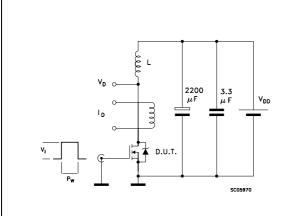
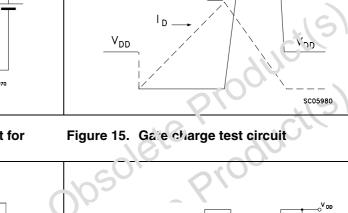


Figure 14. Switching times test circuit for resistive load

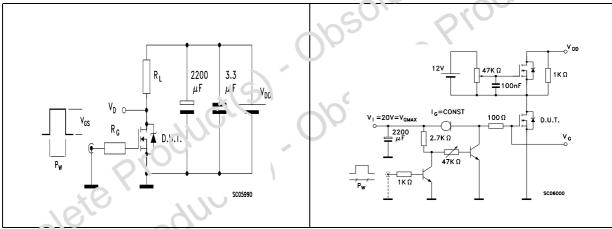


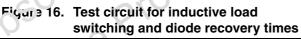


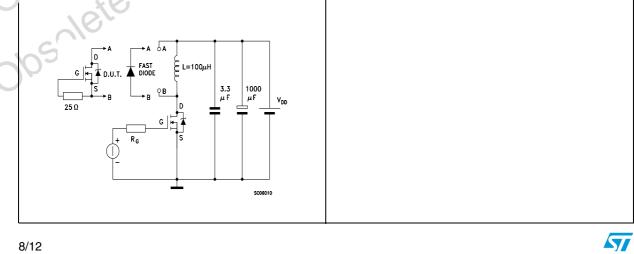
 V_{D}

I _{DM}

V_{(BR)DSS}







4 Package mechanical data

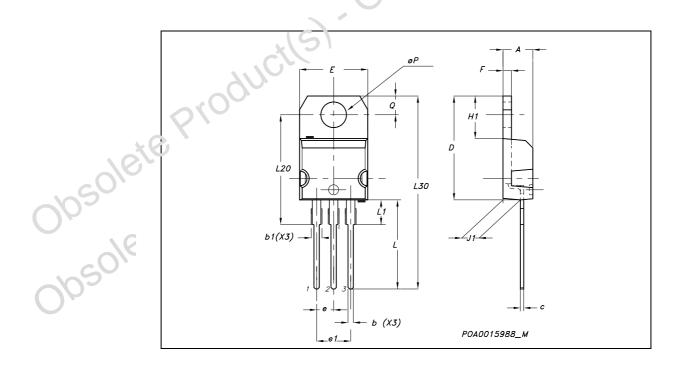
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DIM.		mm.			inch		
DIM.	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.	
А	4.40		4.60	0.173		0.181	
b	0.61		0.88	0.024		0.034	
b1	1.15		1.70	0.045		0.066	
С	0.49		0.70	0.019		0.027	
D	15.25		15.75	0.60		0.620	
E	10		10.40	0.393		0.409	
е	2.40		2.70	0.094		L 100	
e1	4.95		5.15	0.194	11	0.202	
F	1.23		1.32	0.048		0.052	
H1	6.20		6.60	0.244	1202	0.256	
J1	2.40		2.72	0.094		0.107	
L	13		14	0.511		0.551	
L1	3.50		3.93	0.137		0.154	
L20		16.40			0.645		
L30		28.90			1.137		
øР	3.75		3.85	0.147		0.151	
Q	2.65		1 2.85	0.104		0.116	

TO-220 MECHANICAL DATA



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IRF730

5 Revision history

Table 7.	Revision	history
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Date	Revision	Changes
21-Jun-2004	3	Preliminary version
29-Jun-2006	4	New template, no content change

Obsolete Product(s) - Obsolete Product(s) Obsolete Product(s) - Obsolete Product(s)



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